



PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

DPA Components International
2251 Ward Ave, Simi Valley, CA 93065

*(Hereinafter called the Organization) and hereby declares that Organization is accredited
in accordance with the recognized International Standard:*

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the
operation of a laboratory quality management system
(as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

***Acoustical, Chemical, Dimensional Inspection, Electrical, Mechanical
and Non-Destructive***
(As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Tracy Szerszen
President

Initial Accreditation Date:

May 14, 2024

Issue Date:

May 14, 2024

Expiration Date:

July 31, 2026

Accreditation No.:

80864

Certificate No.:

L24-360

Perry Johnson Laboratory
Accreditation, Inc. (PJLA)
755 W. Big Beaver, Suite 1325
Troy, Michigan 48084

*The validity of this certificate is maintained through ongoing assessments based on a
continuous accreditation cycle. The validity of this certificate should be
confirmed through the PJLA website: www.pjllabs.com*



Certificate of Accreditation: Supplement

DPA Components International

2251 Ward Ave, Simi Valley, CA 93065

Contact Name: Aaron Resella Phone: 805-581-9200

Accreditation is granted to the facility to perform the following testing:

FLEX CODE	FIELD OF TEST	ITEMS, MATERIALS, OR PRODUCTS TESTED	COMPONENT, CHARACTERISTIC, PARAMETER TESTED	SPECIFICATION OR STANDARD METHOD	TECHNOLOGY OR TECHNIQUE USED
F1, F2	Non-Destructive ^F	Suspect/Counterfeit EEE Part Detection	Evaluation of counterfeit parts	AS6171/1, Suspect/Counterfeit Test Evaluation Method	Physical evaluation
F1, F2		Suspect/Counterfeit EEE Part Detection	Radiographic Examination	AS6171/5, Techniques for Suspect/Counterfeit EEE Parts Detection by Radiological Test Methods.	Radiological
F1, F2	Mechanical ^F	Suspect/Counterfeit EEE Part Detection	Visual Inspection	AS6171/2, Methods A & B, (A) General EVI, Sample Selection, and Handling, (B) Detailed EVI, including Part Weight measurement.	Visual Evaluation
F1, F2		Suspect/Counterfeit EEE Part Detection	SEM Examination Internal /External	AS6171/2, Methods F Surface Texture Analysis	SEM
F1, F2		Suspect/Counterfeit EEE Part Detection	Visual Inspection	AS6171/2, Methods C & D, Testing for Remarking/ Resurfacing	Visual Evaluation
F1, F2		Suspect/Counterfeit EEE Part Detection	Elemental Content by XRF, EDS	AS6171/3, Techniques for Suspect/Counterfeit EEE Parts Detection	XRF
F1, F2	Dimensional Inspection ^F	Suspect/Counterfeit EEE Part Detection	Dimensions	AS6171/2, Methods E Part Dimensions measurement	Caliper, Gage blocks
F1, F2	Acoustical ^F	Suspect/Counterfeit EEE Part Detection	Acoustic Microscopy (CSAM) Examination/ Inspection	AS6171/6, Techniques for Suspect/Counterfeit EEE Parts Detection	Acoustic Microscopy
F1, F2	Electrical ^F	Suspect/Counterfeit EEE Part Detection	Electrical Tests	AS6171/7 (Table 2) Techniques for Suspect/Counterfeit EEE Parts Detection by Electrical Test Methods.	Software, Ultraflex- Customer provided- Calibration fixture



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F1, F2	Chemical ^F	Suspect/Counterfeit EEE Part Detection	De-capsulation and Die Verification	AS6171/4, Techniques for Suspect/Counterfeit EEE Parts Detection by Delid/Decapsulation Physical Analysis Test Methods.	Visual Evaluation
F1, F2		Suspect/Counterfeit EEE Part Detection	Material Characterization	AS6171/9, Techniques for Suspect/Counterfeit EEE Parts Detection	FTIR
		Suspect/Counterfeit EEE Part Detection	Material Characterization	AS6171/8, Techniques for Suspect/Counterfeit EEE Parts Detection by Raman Spectroscopy Test Methods.	Raman Microscope
F1, F2		Suspect/Counterfeit EEE Part Detection	See Table 2 & 3 AS6171/11	AS6171/11, Techniques for Suspect/Counterfeit EEE Parts Detection by Design Recovery Test Methods	Xray, SEM – Microscope



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Accreditation is granted to the facility to perform the following testing:

- 1 The presence of a superscript F means that the laboratory performs testing of the indicated parameter at its fixed location.
- 2 Flex Code:
 - F1-Introduction of the testing of a new item, material, matrix, or product for an accredited test method
 - F2-Introduction of a new version of an accredited standard method (with no modifications)
 - F3-Introduction of a new parameter/component/analyte to an accredited test method
 - F4- Introduction of a new version or modifications of an accredited non-standard method
 - F5-Introduction of a new method that is equivalent to an accredited method (using same technology or technique)

